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| Notice of References Cited | Application/Control No. 10/541,612 | Applicant(s)/Patent Under Reexamination KEMNITZ ET AL. | |
| | Examiner Patricia L. Hailey | Art Unit 1755 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| * | A | US-4,798,818 | 01-1989 | Baizer et al. | 502/228 |
| * | B | US-5,277,889 | 01-1994 | Power et al. | 423/491 |
| * | C | US-4,275,046 | 06-1981 | McVicker et al. | 423/258 |
| * | D | US-3,644,545 | 02-1972 | Buckman | 570/168 |
| * | E | US-5,051,278 | 09-1991 | Paz-Pujalt, Gustavo R. | 427/108 |
| * | F | US-5,271,956 | 12-1993 | Paz-Pujalt, Gustavo R. | 427/108 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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Patricia L. Hailey